

Proposal for an Independent PDE Measurement of VD X-ARAPUCA Modules @ CERN

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Photon Detection Meeting

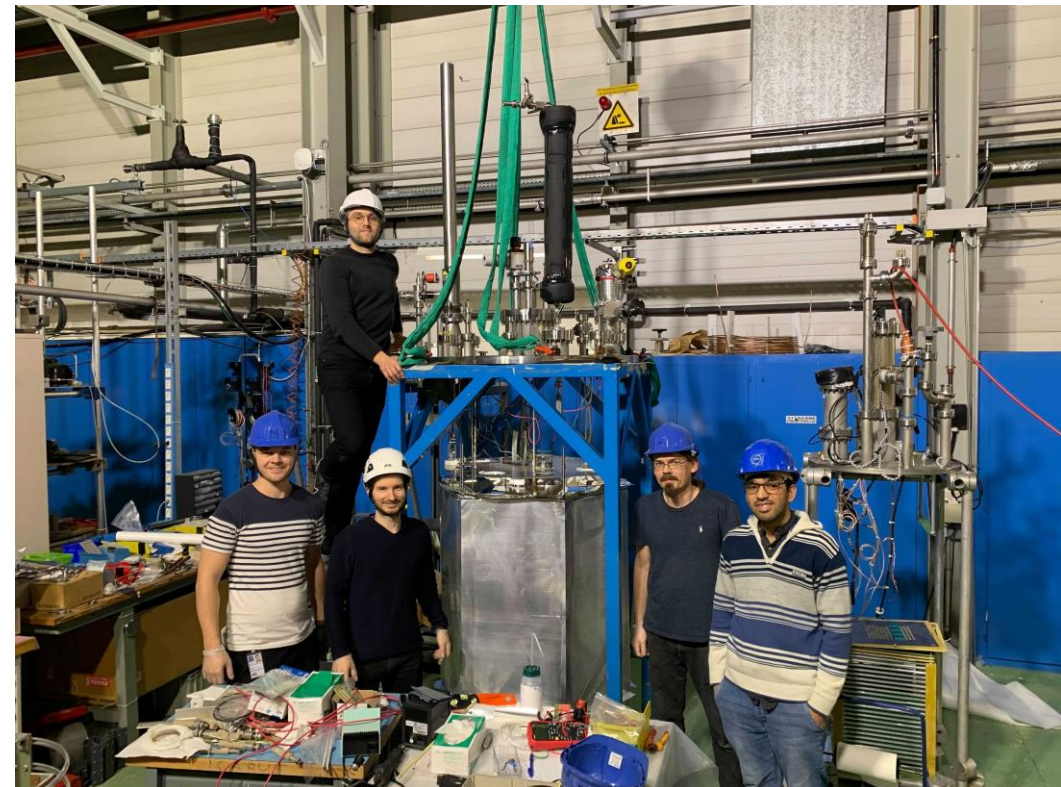
21/03/2023

Motivation

- The absolute PDE for the HD benefitted from having two independent measurements in Italy and Spain
- A facility at CERN is available for an independent measurement; it is already commissioned and currently unused
- The setting up of a VD XA module PED measurement at CERN could happen with a relatively small demand of time and effort, allowing us to cross-check the measurements performed in Naples and possible test different technologies
- This proposal is based on a discussion during this meeting on the 28th of Feb 2023

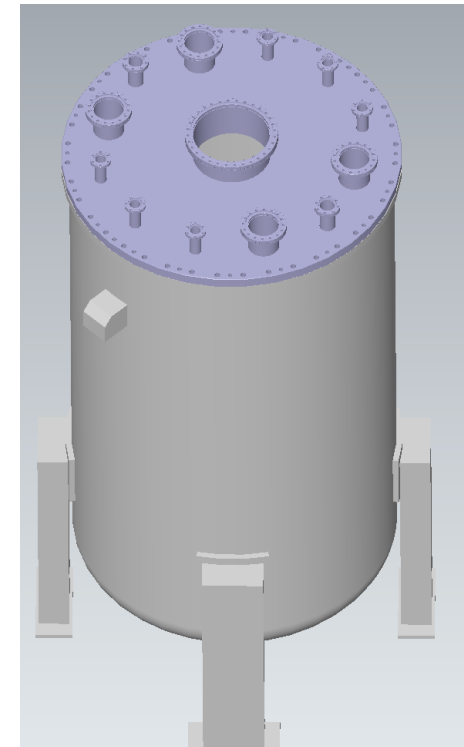
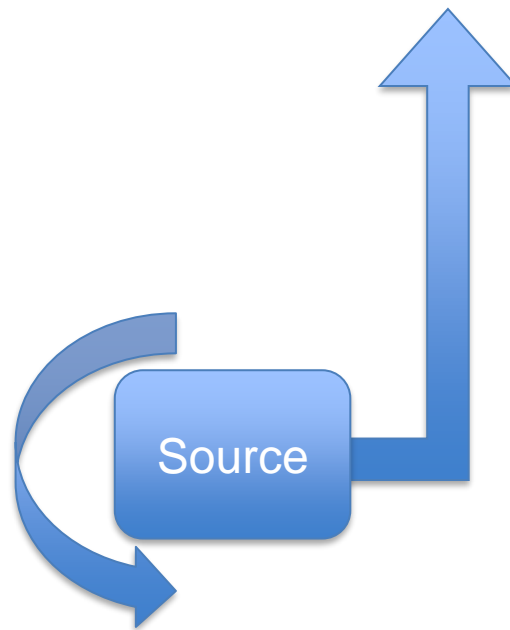
CERN Facility @ Building 182

- The facility consists of a cylindrical cryostat (1.8m deep, 96cm diameter), and a source manipulation arm
- The facility is booked for April for the 200kV feed-through test; it is available before and after that period



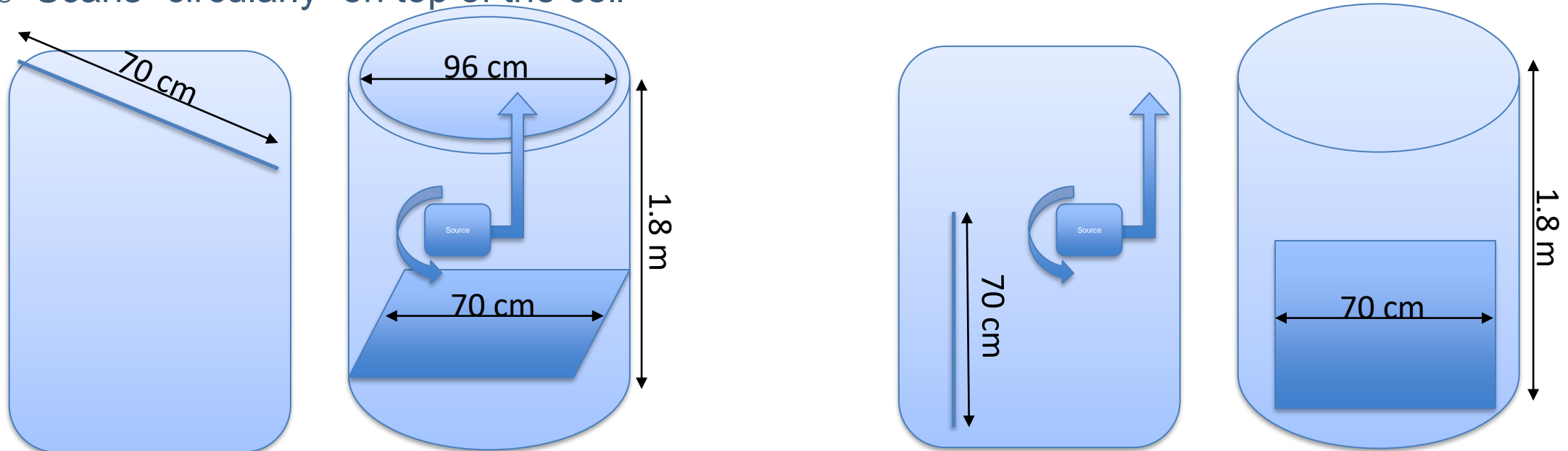
The Dewar

- The cryostat is filled (3 kg/minute) by means of an oxisorb/Hydrosorb filter for high purity ($\tau_t > 1 \mu\text{s}$, constant in time); when full, it consumes 2l LAr/h
- The source manipulation arm can be mounted on any of the Dewar flanges, it moves the source along the z axis and the azimuthal angle



Cell Orientation Inside the Dewar

- The dimension of the cryostat the reach of the source manipulation arm (30-40cm above the bottom) allows for two possible settings
 - Horizontal cell: reduce LAr consumption
 - Need a $\sim 15^\circ$ to fit the cell in the entrance
 - $\sim 0.3 \text{ m}^3$ of LAr to cover cell and source
 - Scans “circularly” on top of the cell
 - Vertical cell: no need to tilt
 - Need twice as much LAr
 - Scans “vertically” on a cell side
 - Can test double-sided cells with two sources



Elements Needed for the Facility

- The XA module will be suspended on the dewar lid, so a mechanical suspension system similar to that designed @ NIU should be produced in advance
- Cryogenic FE and warm-stage electronics (plus cables, connectors, etc.) will be prepared before testing
- An LED system with optical fiber will be purchased
- Finally, we need modules to test, ideally with SiPM from both vendors, which will be exchanged between facilities (Naples, CIEMAT?) to validate and cross-check the PDE measurement as well as testing different technologies
- ..and the manpower

A Module to Test and Someone to Test It

- A VD module to be tested
 - We currently have 4 spare WS Plates available (1 without dimples)
 - Some of the SiPM flexes can be recovered from old modules tested in the cold box
 - A new mechanical frame for the module should be provided by CSU
 - New filters (or spare ones) have to be produced (18 Zaot rectangular spares are currently used in cold box tests)
 - Cold (DMEM & 2 x Cold Amplifiers) + warm electronics available in Milano
- For the manpower, we need >2 people on-site, plus some preparatory work
 - From Milano Bicocca, Alessandro with the help of Carla (preparation of the frame, electronics, module assembly and tests @ CERN)
 - Interest from Valencia to participate, a team of few members needs to be formed

Estimated Costs

- For the LAr we need 300l for a fill w/ horizontal module (~600 € / fill)
- The mechanical framework can be produced in Bicocca (~200 €)
- Missions at CERN (~ 1 k€ / week x person)
- New Zaot Filters (2.3 k€)

Conclusions

- A facility for the PDE measurement of VD modules (of both type Module-0 and Module-1) is available at CERN and can be used in May 2023
- It requires little preparation and employs a system that is already commissioned, allowing us to perform a measurement with a relatively short time span
- We are currently checking all needed elements and costs, to develop a plan for this measurement, as well as assembling a team
- Several elements are available only after the cold box tests (e.g., SiPM flexes)
- This measurement, in collaboration with Naples and other possible sites, gives us the possibility to cross-check the PDE absolute measurement, an approach that was already used for the HD, and test different configurations efficiently